

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
		Examiner Raeann Gorden	Art Unit 3711	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0229183 A1	12-2003	Voorheis et al.	525/232
	B	US-2003/0114246 A1	06-2003	Yokota, Masatoshi	473/351
	C	US-4,955,613	09-1990	Gendreau et al.	473/372
	D	US-6,348,016 B2	02-2002	Nakamura, Atsushi	473/371
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.